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| Substitute Form PTO-1449<br>(Modified)   | U.S. Department of Commerce<br>Patent and Trademark Office | Attorney's Docket No.<br>06181-930001   | Application No.<br>10/747,622 |
| <b>Information Disclosure Statement<br/>by Applicant</b><br>(Use several sheets if necessary)<br>(37 CFR §1.98(b)) |  | Applicant<br><b>Frederick A. Enko</b>   |                               |
|  |  | Filing Date<br><b>December 30, 2003</b> | Group Art Unit<br><b>3711</b> |

**U.S. Patent Documents**

| Examiner Initial | Desig. ID | Document Number | Publication Date | Patentee        | Class | Subclass | Filing Date If Appropriate |
|------------------|-----------|-----------------|------------------|-----------------|-------|----------|----------------------------|
| <i>AA</i>        | AA        | 2002/0163126 A1 | 11/07/2002       | Caldwell        |       |          |                            |
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|                  | AN        |                 |                  |                 |       |          |                            |
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|                  | AP        |                 |                  |                 |       |          |                            |
|                  | AQ        |                 |                  |                 |       |          |                            |
|                  | AR        |                 |                  |                 |       |          |                            |
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**Foreign Patent Documents or Published Foreign Patent Applications**

| Examiner Initial | Desig. ID | Document Number | Publication Date | Country or Patent Office | Class | Subclass | Translation |    |
|------------------|-----------|-----------------|------------------|--------------------------|-------|----------|-------------|----|
|                  |           |                 |                  |                          |       |          | Yes         | No |
|                  | AV        |                 |                  |                          |       |          |             |    |

Examiner Signature

Date Considered

EXAMINER: Initials/citation considered. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.